



**CONFERENCE PROGRAM**

**23<sup>RD</sup> ISSAT INTERNATIONAL CONFERENCE**  
**RELIABILITY and QUALITY in DESIGN**

**CHICAGO, ILLINOIS, U.S.A. ★ AUGUST 3 – 5, 2017**

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D. Gary Harlow (USA)	Shey-Huei Sheu (Taiwan)	

## Keynote Speaker

### Reliability Engineering Challenges in Aerospace Industry

**Dr. Vladimir Crk**

**Engineering Fellow, UTC Aerospace Systems**

UTC Aerospace Systems (UTAS) is a division of the United Technologies Corporation, a worldwide leader in design, development and manufacturing of the complex integrated systems for the commercial and military aerospace, as well as NASA space programs. This talk will focus on numerous challenges UTAS reliability engineers are currently faced with. They result from the fact that the systems hardware and software are extremely complex, design reliability requirements and dispatch reliability requirements continuously increase with the expectation that disruptions, delays and flight cancellations, as well as the cost of the ownership are minimized.

## Awards

### ISSAT RQD 2016 Best Paper Award

#### **System Reliability for a Fast Retransmit through Two Separate Quickest Paths under the Time Constraint**

Cheng-Fu Huang (*Feng Chia University, Taiwan*)

Yi-Kuei Lin (*National Taiwan University of Science and Technology, Taiwan*)

### ISSAT RQD 2016 Best Student Paper Award

#### **Expectation Conditional Maximization Algorithms for Failure Count Non-homogeneous Poisson Process Software Reliability Models**

Vidhyashree Nagaraju (*University of Massachusetts Dartmouth, USA*)

Anusha Krishna Murthy (*University of Massachusetts Dartmouth, USA*)

Lance Fiondella (*University of Massachusetts Dartmouth, USA*)

Panlop Zeepongsekul (*RMIT University, Australia*)

Thierry Wandji (*Naval Air Systems Command, USA*)



## Conference at a Glance

THURSDAY, AUGUST 3	FRIDAY, AUGUST 4	SATURDAY, AUGUST 5
8:00 - 9:00 Registration / Continental Breakfast Roosevelt Foyer	8:00 - 8:30 Registration / Continental Breakfast Roosevelt Foyer	8:00 - 8:30 Registration / Continental Breakfast Roosevelt Foyer
9:00 - 9:15 Welcome - Awards Presentation Roosevelt 3	8:30 - 10:00 Technical Sessions Roosevelt 1 & 3	8:30 - 10:30 Technical Sessions Roosevelt 1 & 3
9:15 - 10:00 Keynote Speech Roosevelt 3	10:00 - 10:15 Coffee Break Roosevelt Foyer	10:30 Adjourn!
10:00 - 10:30 Coffee Break Roosevelt Foyer	10:15 - 11:45 Technical Sessions Roosevelt 1 & 3	
10:30 - 12:00 Technical Sessions Roosevelt 1 & 3	12:00 - 1:00 Conference Luncheon Randolph 1	
1:15 - 2:45 Technical Sessions Roosevelt 1 & 3	1:15 - 2:45 Technical Sessions Roosevelt 1 & 3	
2:45 - 3:00 Coffee Break Roosevelt Foyer	2:45 - 3:00 Coffee Break Roosevelt Foyer	
3:00 - 5:00 Technical Sessions Roosevelt 1 & 3	3:00 - 4:30 Technical Sessions Roosevelt 1 & 3	
5:30 - 7:00 Welcome Reception Plaza Ballroom		

## Technical Sessions at a Glance

	ROOSEVELT 3		ROOSEVELT 1	
Thursday, Aug. 3	Session No.	Title	Session No.	Title
10:30 - 12:00	1	Statistical Reliability Modeling & Applications	2	Network Reliability & Modeling
1:15 - 2:45	3	Reliability in Design and Optimization	4	Software Reliability Measurement and Assessment
3:00 - 5:00	5	Maintenance Optimization and Applications	6	Accelerated Degradation Tests and Modeling

	ROOSEVELT 3		ROOSEVELT 1	
Friday, Aug. 4	Session No.	Title	Session No.	Title
8:30 - 10:00	7	Software Engineering, Reliability and Security Analysis	8	System Reliability and Maintenance Optimization
10:15 - 11:45	9	Reliability/Maintenance Modeling and Applications	10	Reliability, Safety and Risk Assessment
1:15 - 2:45	11	Software and System Reliability Modeling & Applications	12	Engineering Reliability and Applications
3:00 - 4:30	13	Reliability Analysis and Optimization	14	Performance Modeling and Simulation

	ROOSEVELT 3		ROOSEVELT 1	
Saturday, Aug. 5	Session No.	Title	Session No.	Title
8:30 - 10:30	15	Integrated Reliability and Safety Analysis	16	Reliability Optimization

# Technical Sessions

## SESSION 1: Statistical Reliability Modeling & Applications

**Chair: Prof. D. Gary Harlow** (*Lehigh University, USA*)

### Analyzing Visitors' Characteristics in Tourist Areas Based on Mobile Phone Users' Location Data

Masahide Yamamoto (*Nagoya Gakuin University, Japan*)

### The ELECTRE I Method to Optimise GPR Data Processing Analyses for Maintenance of Water Networks

Silvia Carpitella (*University of Palermo, Italy*)

Silvia J. Ocana-Levario (*Universitat Politècnica de València, Spain*)

Julio Benítez (*Universitat Politècnica de València, Spain*)

Antonella Certa (*University of Palermo, Italy*)

Mario Enea (*University of Palermo, Italy*)

Joaquín Izquierdo (*Universitat Politècnica de València, Spain*)

### Importance Analysis for Typical Parts of Civil Airplane Slat Considering Performance Degradation

Changcong Zhou (*Northwestern Polytechnical University, China*)

Chenghu Tang (*Northwestern Polytechnical University, China*)

Fuchao Liu (*Northwestern Polytechnical University, China*)

Zheng Zhang (*Northwestern Polytechnical University, China*)

### Empirical Confidence Bounds

D. Gary Harlow (*Lehigh University, USA*)

## SESSION 2: Network Reliability & Modeling

**Chair: Prof. Yi-Kuei Lin** (*National Taiwan University of Science & Technology, Taiwan*)

### Markov Chain Monte Carlo Approach for Burr Type XII Distribution

Jianping Zhu (*Northeast Petroleum University, China*)

Hua Xin (*Northeast Petroleum University, China*)

Junge Sun (*Xiamen University, China*)

Tzong-Ru Tsai (*Tamkang University, Taiwan*)

### A Practical Preventive Maintenance for Aging Multi-State K-out-of-n Systems

Chun-Ho Wang (*National Defense University, Taiwan*)

Chao-Hui Huang (*R.O.C. Naval Academy, Taiwan*)

### System Reliability Estimation for a Manufacturing Network with Joint Buffers

Ping-Chen Chang (*National Quemoy Univ., Taiwan*)

Yi-Kuei Lin (*National Taiwan Univ of Sci & Tech, Taiwan*)

### Stochastic Flow Distribution Network of Multiple Sinks with Inventory Consideration

Cheng-Fu Huang (*Feng Chia University, Taiwan*)

Yi-Kuei Lin (*National Taiwan Univ of Sci & Tech, Taiwan*)

Man-Ju Chuang (*National Taiwan Univ of Sci & Tech, Taiwan*)

## SESSION 3: Reliability in Design and Optimization

**Chair: Dr. Feng-Bin Sun** (*Tesla Motors, USA*)

### Time-Dependent Global Reliability Sensitivity Analysis of Mechanisms with Correlated Random Input Variables

Pengfei Wei (*Northwestern Polytechnical University, China*)

Wenxuan Wang (*Northwestern Polytechnical University, China*)

### Framing Reliability Specification in Early Design Phase of Subsea Systems

Juntao Zhang (*Norwegian University of Science and Technology, Norway*)

Yiliu Liu (*Norwegian University of Science and Technology, Norway*)

Mary Ann Lundteigen (*Norwegian University of Science and Technology, Norway*)

### A Goal Programming Model for Network Reliability Design Problem

Seyedmohsen Hosseini (*Center for Logistics, Trade, and Transportation, USA*)

MD Sarder (*Bowling Green State University, USA*)  
Ahmed Islam (*Center for Logistics, Trade, and  
Transportation, USA*)

#### **Time-Dependent Meta-Models for Dynamic Systems with Nonparametric Excitations**

Gordon J. Savage (*University of Waterloo, Canada*)  
Young Kap Son (*Andong National University, South  
Korea*)

#### **SESSION 4: Software Reliability Measurement and Assessment (in honor of Prof. Shigeru Yamada)**

**Chair: Prof. Shinji Inoue** (*Kansai University, Japan*)

#### **A Hybrid Approach to Identify the Maximum Likelihood Estimates of a Two Change-point Goel-Okumoto Software Reliability Growth Model**

Vidhyashree Nagaraju (*University of Massachusetts  
Dartmouth, USA*)  
Lance Fiondella (*University of Massachusetts  
Dartmouth, USA*)  
Thierry Wandji (*Naval Air Systems Command, USA*)

#### **Change-Point Modeling for Software Reliability Assessment under Imperfect Debugging Environment**

Shinji Inoue (*Kansai University, Japan*)  
Hiroyuki Inaba (*Tottori University, Japan*)  
Shigeru Yamada (*Tottori University, Japan*)

#### **Software Reliability Modeling with Considerations of Two-Phase Imperfect Debugging and Fault Removal**

Mengmeng Zhu (*Rutgers University, USA*)  
Hoang Pham (*Rutgers University, USA*)

#### **On Bayesian Estimation for Software Reliability Assessment Based on a Discrete NHPP Model**

Shinji Inoue (*Kansai University, Japan*)  
Shigeru Yamada (*Tottori University, Japan*)

#### **SESSION 5: Maintenance Optimization and Applications (in honor of Professor Shigeru Yamada)**

**Chair: Prof. Shouji Nakamura** (*Kinjo Gakuin University,  
Japan*)

#### **Age Replacement Policies with Shortage and Excess Costs**

Mingchih Chen (*Fu Jen Catholic University, Taiwan*)  
Xufeng Zhao (*Qatar University, Qatar*)  
Toshio Nakagawa (*Aichi Institute Of Technology,  
Japan*)

#### **Three Maintenances for Age Replacement Policies**

Xufeng Zhao (*Qatar University, Qatar*)  
Khalifa N. Al-Khalifa (*Qatar University, Qatar*)  
Cunhua Qian (*Nanjing Tech University, China*)  
Toshio Nakagawa (*Aichi Institute Of Technology,  
Japan*)

#### **Optimal Maintenance Strategy for Second-hand Product Under Repair-replacement Policy**

Minjae Park (*Hongik University, Korea*)  
Ki Mun Jung (*Kyungsung University, Korea*)  
Dong Ho Park (*Hallym University, Korea*)

#### **A Survey of Continuous Failure Rates and Their Applications to Replacement Policies**

Toshio Nakagawa (*Aichi Institute Of Technology,  
Japan*)  
Xufeng Zhao (*Qatar University, Qatar*)

#### **Cumulative Backup Policies for Database Systems**

Shouji Nakamura (*Kinjo Gakuin University, Japan*)  
Masashi Yamakawa (*Kinjo Gakuin University, Japan*)  
Xufeng Zhao (*Qatar University, Qatar*)

#### **SESSION 6: Accelerated Degradation Tests and Modeling Chair: Prof. Elsayed A. Elsayed (Rutgers Univ. USA)**

#### **Design an Optimal Plan of Accelerated Degradation Test with Acceleration Factor Constant Principle**

Hao-Wei Wang (*Naval Aeronautical and Astronautical  
University, China*)  
Fei Teng (*Naval Aeronautical and Astronautical  
University, China*)

#### **Planning Optimal Degradation Tests in Consideration of Budget and Statistic Accuracy on Different Stress Levels**

Zeljana Beslic (*University of Stuttgart, Germany*)  
Peter Müller (*University of Stuttgart, Germany*)  
Shuang Yan (*University of Stuttgart, Germany*)  
Bernd Bertsche (*University of Stuttgart, Germany*)

**Acceleration Reliability Growth Tests under Double-stresses**

Jinyong Yao (*Beihang University, China*)  
Hao Wu (*Beihang University, China*)  
Yiliu Liu (*Norwegian University of Science and Technology, Norway*)  
Xiangfen Wang (*Beihang University, China*)

**Estimating Activation Energy of the LiFePO<sub>4</sub> Battery Using Dual Dynamic Stress Accelerated Degradation Tests**

Yu-Chang Lin (*National Changhua University of Education, Taiwan*)  
Yi-Ru Li (*National Changhua University of Education, Taiwan*)  
Kuan-Jung Chung (*National Changhua University of Education, Taiwan*)

**Optimal Operational Selection and Sequencing of Systems with Mixtures of One-Shot Units**

Yao Cheng (*Rutgers University, USA*)  
Elsayed A. Elsayed (*Rutgers University, USA*)

**SESSION 7: Software Engineering, Reliability and Security Analysis**

**Chair: Prof. Taghi M. Khoshgoftaar** (*Florida Atlantic Univ., USA*)

**Performance of Feature Subset Evaluators for Software Engineering Datasets**

Huanjing Wang (*Western Kentucky University, USA*)  
Taghi M. Khoshgoftaar (*Florida Atlantic University, USA*)  
Kehan Gao (*Eastern Connecticut State University, USA*)

**A Framework for Capturing HTTP GET DDoS Attacks on a Live Network Environment**

Chad Calvert (*Florida Atlantic University, USA*)  
Clifford Kemp (*Florida Atlantic University, USA*)  
Taghi M. Khoshgoftaar (*Florida Atlantic University, USA*)  
Maryam M. Najafabadi (*Florida Atlantic University, USA*)

**Effective Selection of Packet Header Fields For Detection of Man In The Middle Attacks in LAN Environments**

Maryam M. Najafabadi (*Florida Atlantic University, USA*)

Taghi M. Khoshgoftaar (*Florida Atlantic University, USA*)

Chad Calvert (*Florida Atlantic University, USA*)

Clifford Kemp (*Florida Atlantic University, USA*)

**Analysis of a Transfer Learning Application Using the Transfer Learning Test Framework**

Karl R. Weiss (*Florida Atlantic University, USA*)  
Taghi M. Khoshgoftaar (*Florida Atlantic University, USA*)

**SESSION 8: System Reliability and Maintenance Optimization**

**Chair: Prof. Yao Hsu** (*Kainan University, Taiwan*)

**An Efficient Algorithm to Solve the Maximal Flow Problems**

Shin-Guang Chen (*Tungnan University, Taiwan*)

**Extended Optimal Replacement Policy Based on Cumulative Damage for a Two-Unit System Subject to Shocks**

Shey-Huei Sheu (*Providence University, Taiwan*)  
Tzu-Hsin Liu (*Providence University, Taiwan*)  
Zhe-George Zhang (*Western Washington University, USA*)  
Hsin-Nan Tsai (*Providence University, Taiwan*)

**Network Reliability for Flight Routes with Time and Stopover Constraints**

Phuong Thi Nguyen (*National Taiwan University of Science and Technology, Taiwan*)  
Yi-Kuei Lin (*National Taiwan University of Science and Technology, Taiwan*)

**Reliability Analysis of High-Power LED Assemblies of Street Light under Thermal Environments**

Yao Hsu (*Kainan University, Taiwan*)  
Wen-Fang Wu (*National Taiwan University, Taiwan*)  
Cheng-Hua Wang (*National Taiwan University, Taiwan*)

**SESSION 9: Reliability/Maintenance Modeling and Applications (in honor of Prof. Shigeru Yamada)**

**Chair: Prof. Yoshinobu Tamura** (*Tokyo City University, Japan*)



**Reliability Modelling of Window Flow Control Scheme for a Communication System based on Packet Transmission Interval**

Mitsutaka Kimura (*Gifu City Women's College, Japan*)  
Mitsuhiro Imaizumi (*Aichi Gakusen University, Japan*)  
Toshio Nakagawa (*Aichi Institute Of Technology, Japan*)

**A Two-Stage Policy for a Server System With Illegal Access**

Mitsuhiro Imaizumi (*Aichi Gakusen University, Japan*)  
Mitsutaka Kimura (*Gifu City Women's College, Japan*)

**Optimal Self Inspection Policies of Self-service Retailers**

Kodo Ito (*Fukushima University, Japan*)  
Yoshiyuki Higuchi (*Fukushima University, Japan*)  
Masao Ohta (*Fukushima University, Japan*)  
Xiaoyuan Liu (*AEON Co.,Ltd., Japan*)

**Optimization and Reliability Analysis Tool Based on Multi-Dimensional Wiener Processes for Big Data on Cloud Computing**

Yoshinobu Tamura (*Tokyo City University, Japan*)  
Shigeru Yamada (*Tottori University, Japan*)

**SESSION 10: Reliability, Safety and Risk Assessment**

**Chair: Dr. Mingxiao Jiang** (*Medtronic, Plc., USA*)

**Design Option Analysis of SRAM-based FPGAs in Safety-Critical Systems**

Xiangfen Wang (*Beihang University, China*)  
Yiliu Liu (*Norwegian University of Science and Technology, Norway*)  
Mary Ann Lundteigen (*Norwegian University of Science and Technology, Norway*)  
Cheng Gao (*Beihang University, China*)  
Jiaoying Huang (*Beihang University, China*)

**Research of Reliability Evaluation Method Based on Optimal Parameter Estimation**

Jianjun Ma (*University of Shanghai for Science and Technology, China*)  
Songlin Zheng (*University of Shanghai for Science and Technology, China*)  
Tie Chen (*University of Shanghai for Science and Technology, China*)  
Jinzhi Feng (*University of Shanghai for Science and Technology, China*)

Lihui Zhao (*University of Shanghai for Science and Technology, China*)

**Comparisons of Endurance Time Models in the Prediction of Pulling Tasks**

Kai Way Li (*Chung Hua University, China*)  
Fan Tang (*Hunan Institute of Technology, China*)  
Cannan Yi (*Hunan Institute of Technology, China*)  
Lu Peng (*Hunan Institute of Technology, China*)

**Risk Assessment with Causality Measurement**

Mingxiao Jiang (*Medtronic, Plc., USA*)  
Feng-Bin Sun (*Tesla, Inc., USA*)

**SESSION 11: Software and System Reliability Modeling & Applications (in honor of Prof. Shigeru Yamada)**

**Chair: Prof. Satoshi Fukumotoz** (*Tokyo Metropolitan University, Japan*)

**Software Reliability Modeling Approaches with Test Environmental Factors**

Ailin Li (*Tottori University, Japan*)  
Shinji Inoue (*Kansai University, Japan*)  
Shigeru Yamada (*Tottori University, Japan*)

**Human Reliability Analysis to Support the Development of a Software Project**

Silvia Carpitella (*Università degli Studi di Palermo, Italy*)  
Antonella Certa (*Università degli Studi di Palermo, Italy*)  
Mario Enea (*Università degli Studi di Palermo, Italy*)  
Giacomo Maria Galante (*Università degli Studi di Palermo, Italy*)  
Joaquín Izquierdo (*Universitat Politècnica de València, Spain*)  
Concetta Manuela La Fata (*Università degli Studi di Palermo, Italy*)

**A Note on an Optimal Maintenance Policy for a Markovian Deteriorating System Subject to Random Shocks**

Nobuyuki Tamura (*Hosei University, Japan*)

**A Synchronous Software Rejuvenation Technique for Time Warp Event Simulation**

Mamoru Ohara (*Tokyo Metropolitan Industrial  
Technology Research Institute, Japan*)  
Satoshi Fukumoto (*Tokyo Metropolitan University,  
Japan*)

## **SESSION 12: Engineering Reliability and Applications**

**Chair: Prof. Dong Ho Park** (*Hallym University, Korea*)

### **Reliability Analysis of Complex Welded Aluminium Alloy Structural Part**

Xiaowei Yin (*Shenyang Institute of Engineering, China*)  
Changhui Yao (*Northeastern University, China*)  
Wenxue Qian (*Northeastern University, China*)  
Liyang Xie (*Northeastern University, China*)

### **Three-Parameter vs. Two-Parameter Weibull Model for Single Fiber Strength**

Ningxiang Wu (*Northeastern University, China*)  
Liyang Xie (*Northeastern University, China*)

### **Analysis of Thermal Characteristics of Aircraft Gearbox Based on Thermal Network Method**

Xingfu Zhao (*Beihang University, China*)  
Guanhua Song (*Beihang University, China*)  
Yidu Zhang (*Beihang University, China*)  
Yanzhong Wang (*Beihang University, China*)  
Delong Dou (*Beihang University, China*)

### **On the Shape of Failure Rate Curve and Influencing Factors**

Liyang Xie (*Northeastern University, China*)  
Bo Qin (*Northeastern University, China*)

## **SESSION 13: Reliability Analysis and Optimization**

**Chair: Prof. B.S Dhillon** (*University of Ottawa, Canada*)

### **Optimal Reliability of Series and Parallel Systems subject to Two Failure Modes Considering Correlated Failures**

Anusha Krishna Murthy (*University of Massachusetts  
Dartmouth, USA*)  
Saikath Bhattacharya (*University of Massachusetts  
Dartmouth, USA*)  
Lance Fiondella (*University of Massachusetts  
Dartmouth, USA*)

### **Reliability Analysis Method For Three-State Nuclear Power Electrical Systems Based On Goal Oriented Methodology**

Ming-chao Lu (*Shanghai Nuclear Engineering Research  
& Design Institute, China*)  
Xiao-jian Yi (*China North Industries Group Corp., China*)  
Jian-feng Chen (*Shanghai Nuclear Engineering  
Research & Design Institute, China*)  
Yong-jun Bai (*Shanghai Nuclear Engineering Research  
& Design Institute, China*)  
Hui-na Mu (*Beijing Institute of Technology, China*)

### **Expected Waiting Time of Demand Responsive Transport with a Waiting Point**

Junji Koyanagi (*Tottori University, Japan*)  
Kensuke Takemoto (*Tottori University, Japan*)

### **Mining Equipment Reliability: An Investigative Study**

B.S Dhillon (*University of Ottawa, Canada*)

## **SESSION 14: Performance Modeling and Simulation**

**Chair: Prof. Hoang Pham** (*Rutgers University, USA*)

### **Security Analysis of Airborne Transmitter's Thread Connection Based on Finite Element Simulation Technology**

Yan-zhong Wang (*Beihang University, China*)  
Peng Liu (*Beihang University, China*)  
Jing-bo Guo (*ShiJiaZhuang Tie Dao University, China*)  
Xue-miao Cui (*Liaoning University of Technology,  
China*)

### **Research on Load Spectrum of CNC Machine Tool Based on Cutting Current Signal**

Ying Wu (*Huazhong University of Science and  
Technology, China*)  
Bin Li (*Huazhong University of Science and Technology,  
China*)  
Jindong Li (*Yunke Intelligent Manufacturing  
(Shenyang) Co., Ltd, China*)  
Subao Ding (*Huazhong University of Science and  
Technology, China*)

### **Performance Analysis and Design Improvement of a Sludge Dewatering System**

Derrick C.P. Ng (*The Hong Kong Polytechnic University,  
Hong Kong SAR*)

Eric T.T. Wong (*The Hong Kong Polytechnic University, Hong Kong SAR*)

Subhashis Chatterjee (*Indian Institute of Technology, India*)

Bhagyashree Chaudhuri (*Indian Institute of Technology, India*)

### **Simulation Specimen Design Method of Aeroengine Compressor Disk**

Wenxue Qian (*Northeastern University, China*)  
Jiyao Liu (*Northeastern University, China*)  
Yankai Yuan (*Northeastern University, China*)  
Xiaowei Yin (*Shenyang Institute of Engineering, China*)  
Liyang Xie (*Northeastern University, China*)

### **Use Pyramidal Distribution for Multivariate Uniformity Test Power Comparison**

Zhenmin Chen (*Florida International University, USA*)

## **SESSION 15: Integrated Reliability and Safety Analysis**

**Chair: Prof. Zhenmin Chen** (*Florida International University, USA*)

## **SESSION 16: Reliability Optimization**

**Chair: Dr. Manwinder Kaur** (*General Shivdev Singh Diwan Gurbachan Singh Khalsa College, India*)

### **Non-repairable Multi-state Consecutive 2-out-of- $n$ Failed Systems subject to Correlated Failures**

Bentolhoda Jafary (*University of Massachusetts Dartmouth, USA*)  
Lance Fiondella (*University of Massachusetts Dartmouth, USA*)

### **A Modified Proximal Gradient Method for a Class of Sparse Optimization Problems**

Yingyi Li (*Beijing University of Technology, China*)  
Haibin Zhang (*Beijing University of Technology, China*)

### **Random Vibration Analysis of a New Type of EMU CFRP Equipment Cabin Frame**

Yong-Yan Wang (*Qingdao University of Science & Technology, China*)  
Xiang-Feng Zhang (*Qingdao University of Science & Technology, China*)  
Yue-Li Han (*Qingdao University of Science & Technology, China*)  
Yu-Biao Zhang (*Qingdao University of Science & Technology, China*)  
Xiu-Wen Shi (*Qingdao University of Science & Technology, China*)

### **Reliability and importance measures for Combined $m$ -Consecutive- $k$ -out-of- $n$ : F and Consecutive- $k_b$ -out-of- $n$ : F Systems with non-homogeneous Markov-dependent components**

Mahmoud Boushaba (*Ecole Normale Supérieure de Constantine, Algeria*)  
Azzedine Benyahia (*Ecole Normale Supérieure de Constantine, Algeria*)

### **Design, Build and Test an Innovative Tail-Sitter Unmanned Aerial Vehicle (UAV)**

Yiming Zhang (*The Hong Kong Polytechnic University, Hong Kong SAR*)  
Weichen Xu (*The Hong Kong Polytechnic University, Hong Kong SAR*)  
Guangyi Chen (*The Hong Kong Polytechnic University, Hong Kong SAR*)

### **A Method of Optimization Selecting Test Points by Inverse Process**

Wenkui Hou (*Beihang University, China*)  
Zhiming Zhang (*Beihang University, China*)

### **Modal Analysis and Crack Propagation Residual Life Prediction of Vibrating Screen Beam**

Zerong Zhang (*Qingdao University of Science and Technology, China*)  
Yongyan Wang (*Qingdao University of Science and Technology, China*)  
Zhimin Fan (*Qingdao University of Science and Technology, China*)

### **Performance Analysis of Change Point based Software Reliability Growth Model Incorporating Both Fault Reduction Factor and Test Coverage**

Ankur Shukla (*Indian Institute of Technology, India*)

### **Duplex Paper Industry (Manufacturing Process and its Performance Analysis)**

Aakash Deep Sharma (*Sri Guru Granth Sahib World University, India*)  
Manwinder Kaur (*General Shivdev Singh Diwan Gurbachan Singh Khalsa College, India*)

**Thank you for contributing and participating  
in the 23<sup>rd</sup> ISSAT RQD conference**

**We hope you enjoy the entire program**



**Save  
the Date!**

**RQD 2018**

**24<sup>th</sup> ISSAT International Conference  
RELIABILITY AND QUALITY IN DESIGN**

**Toronto, Ontario, Canada**

**August 2-4, 2018**

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